

Belec Spektrometrie
 Opto-Elektronik GmbH

OES CALIBRATION SPECIFICATIONS

Instrument : Belec OPTRON
 Matrix : Al - Base

	Al	Al	Al- Si > 5%
X	Si	0.01 - 5.0	0.1 - 24.0
X	Fe	0.01 - 3.2	0.01 - 1.5
X	Cu	0.01 - 9.5	0.01 - 4.5
X	Mn	0.01 - 1.5	0.01 - 1.0
X	Mg	0.01 - 10.2	0.01 - 2.5
X	Zn	0.01 - 11	0.01 - 11
X	Ni	0.01 - 3.5	0.01 - 3.5
X	Cr	0.01 - 0.45	0.01 - 0.2
X	Pb	0.01 - 1.6	0.01 - 0.2
X	Sn	0.01 - 1.0	0.01 - 1.0
X	Ti	0.01 - 0.3	0.01 - 0.25
X	Be	0.01 - 0.05	0.01 - 0.05
X	Zr	0.01 - 0.2	0.01 - 0.2
X	Co	0.01 - 0.3	0.01 - 0.3
X	V	0.01 - 0.15	0.01 - 0.15
O	Ag	0.01 - 0.7	0.01 - 0.7

X = Standard configuration
O = Optional

Additional elements or wider ranges on request